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L Number	Hits	Search Text	DB	Time stamp
1	18166	(carbon C) near6 (SiO SiO2 "Si.sub.2" ((silicon Si) adj (oxide	USPAT;	2004/02/18 16:07
		dioxide)))	US-PGPUB;	
			EPO; JPO;	
			DERWENT;	
			IBM_TDB	
2	42831	low adj2 (k kappa dielectric constant permitivity permittivity)	USPAT;	2004/02/18 15:48
			US-PGPUB;	
			EPO; JPO;	
	•		DERWENT;	
1			IBM_TDB	
3	592	((carbon C) near6 (SiO SiO2 "Si.sub.2" ((silicon Si) adj (oxide	USPAT;	2004/02/18 16:08
		dioxide)))) same (low adj2 (k kappa dielectric constant	US-PGPUB;	
		permitivity permittivity))	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
4	95	(((carbon C) near6 (SiO SiO2 "Si.sub.2" ((silicon Si) adj	USPAT;	2004/02/18 16:08
		(oxide dioxide)))) same (low adj2 (k kappa dielectric constant	US-PGPUB;	
		permitivity permittivity))) and @ad<19990630	EPO; JPO;	
			DERWENT;	
			IBM_TDB	0004/00/40 45:40
5	76	(((carbon C) near6 (SiO SiO2 "Si.sub.2" ((silicon Si) adj	USPAT;	2004/02/18 15:49
		(oxide dioxide)))) same (low adj2 (k kappa dielectric constant	US-PGPUB;	
]		permitivity permittivity))) and @rlad<19990630	EPO; JPO;	
			DERWENT;	
		444 1 0) 0 (0) 0 0) 00 H0; 1 0H ((-)H	IBM_TDB	2004/02/19 15:52
6	140	((((carbon C) near6 (SiO SiO2 "Si.sub.2" ((silicon Si) adj	USPAT;	2004/02/18 15:52
		(oxide dioxide)))) same (low adj2 (k kappa dielectric constant	US-PGPUB;	
		permittivity permittivity))) and @ad<19990630) ((((carbon C)	EPO; JPO;	
		near6 (SiO SiO2 "Si.sub.2" ((silicon Si) adj (oxide dioxide))))	DERWENT; IBM_TDB	
		same (low adj2 (k kappa dielectric constant permitivity	I IDIVI_I DB	
_	5550	permittivity))) and @rlad<19990630) (carbon) near6 (SiO SiO2 "Si.sub.2" ((silicon Si) adj (oxide	USPAT;	2004/02/18 16:07
7	5556		US-PGPUB;	2004/02/10 10:07
		dioxide)))	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
8	481	((carbon) near6 (SiO SiO2 "Si.sub.2" ((silicon Si) adj (oxide	USPAT;	2004/02/18 16:08
6		dioxide)))) same (low adj2 (k kappa dielectric constant	US-PGPUB;	
		permitivity permittivity))	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
9	49	(((carbon) near6 (SiO SiO2 "Si.sub.2" ((silicon Si) adj (oxide	USPAT;	2004/02/18 16:08
		dioxide)))) same (low adj2 (k kappa dielectric constant	US-PGPUB;	
		permitivity permittivity))) and @ad<19990630	EPO; JPO;	
]	DERWENT;	
			IBM_TDB	
10	48	(((carbon) near6 (SiO SiO2 "Si.sub.2" ((silicon Si) adj (oxide	USPAT;	2004/02/18 16:08
		dioxide)))) same (low adj2 (k kappa dielectric constant	US-PGPUB;	
		permitivity permittivity))) and @rlad<19990630	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
11	82	((((carbon) near6 (SiO SiO2 "Si.sub.2" ((silicon Si) adj (oxide	USPAT;	2004/02/18 16:08
		dioxide)))) same (low adj2 (k kappa dielectric constant	US-PGPUB;	
		permitivity permittivity))) and @ad<19990630) ((((carbon)	EPO; JPO;	
		near6 (SiO SiO2 "Si.sub.2" ((silicon Si) adj (oxide dioxide))))	DERWENT;	
		same (low adj2 (k kappa dielectric constant permitivity	IBM_TDB	
1		permittivity))) and @rlad<19990630)		